



Extreme-Environment Electronics: Challenges and Solutions

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Deadline for manuscript
submissions:

closed (31 October 2021)

Message from the Guest Editor

In recent years, research and investigations into extreme-environment electronics have been actively conducted. In the initial design phase, accurate predictions and evaluations are critically important because electronics operating in harsh environments can exhibit significant long- and short-term performance degradation.

Successful implementation requires accurate modeling of operating conditions, appropriate calibration methods, degradation simulations, and performance measurement. In addition, due to aggressive technology scaling and system integration, it is essential to develop efficient design and test techniques relevant to extreme-environment electronics.

The topics to be covered in this Special Issue are as follows:

- Investigation of radiation effects in electronics;
- Radiation-hardening design approaches and techniques;
- Design, simulation, measurement, and new applications of extreme-environment electronics;
- Cryogenic/high-temperature operation and related issues;
- Electronic systems for nuclear power plants and facilities;
- Electronics in other harsh conditions such as mechanical and chemical stress.

Welcome to contribute.





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Message from the Editor-in-Chief

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Journal Rank: JCR - Q2 (*Electrical and Electronic Engineering*) CiteScore - Q2 (*Electrical and Electronic Engineering*)

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